

RDS(ON),max.

2.1mΩ

Drain

Gate

TO-263-2L

Gate

Source

D<sup>[2]</sup>

232A

Drain

Source

**BV**<sub>DSS</sub>

40V

TO-220-3L

# 40V N-ch Power MOSFET

#### **General Features**

- Proprietary New Trench Technology
- $> R_{DS(ON),typ} = 1.65 m\Omega @V_{GS} = 10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

#### **Applications**

- High efficiency DC/DC Converters
- Synchronous Rectification
- UPS Inverter

# **Ordering Information**

Part Number	Package	Marking		
FTP40N2P1L	TO-220-3L	40N2P1L		
FTB40N2P1L	TO-263-2L	40N2P1L		

## **Absolute Maximum Ratings**

 $T_C {=} 25 ^{\circ} {\rm C}$  unless otherwise specified

Symbol	Parameter	Value	Unit	
V <sub>DSS</sub>	Drain-to-Source Voltage <sup>[1]</sup>	40	- V	
V <sub>GSS</sub>	Gate-to-Source Voltage	±20		
	Continuous Drain Current <sup>[2]</sup>	232		
Ι <sub>D</sub>	Continuous Drain Current <sup>[3]</sup>	192	А	
	Continuous Drain Current at $T_c$ =100 $^{\circ}C^{[2]}$	164	,,	
I <sub>DM</sub>	Pulsed Drain Current at V <sub>GS</sub> =10V <sup>[2,4]</sup>	926	┨	
E <sub>AS</sub>	Single Pulse Avalanche Energy $(V_{DD}=30V, V_{GS}=10V, R_G=25\Omega, L=1mH)$	250	mJ	
D	Power Dissipation	221	W	
PD	Derating Factor above 25℃	1.5	W/℃	
TL	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	°C	
T <sub>J</sub> & T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 175	U	

Gate

Drain Source

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

# **Thermal Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Unit
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case			0.68	°C 1.11
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient			63	°C/W

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# **Electrical Characteristics**

OFF	<b>Characteristics</b>	
	Characteristics	

Parameter Drain-to-Source Breakdown Voltage Drain-to-Source Leakage Current Gate-to-Source Leakage Current acteristics Parameter Static Drain-to-Source	Min. 40 Min.	Тур.	Max. 1 ±100	Unit V uA	Test Conditions V <sub>GS</sub> =0V, I <sub>D</sub> =250uA V <sub>DS</sub> =32V, V <sub>GS</sub> =0V	
Drain-to-Source Leakage Current Gate-to-Source Leakage Current acteristics Parameter Static Drain-to-Source				uA		
Gate-to-Source Leakage Current acteristics Parameter Static Drain-to-Source	Min.				V <sub>DS</sub> =32V, V <sub>GS</sub> =0V	
Acteristics Parameter Static Drain-to-Source	Min.		±100	•		
Parameter Static Drain-to-Source	Min.	1		nA	$V_{GS}$ =±20V, $V_{DS}$ =0V	
Static Drain-to-Source	Min.			TJ=	25 $^\circ \!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!\!$	
		Тур.	Max.	Unit	Test Conditions	
		1.65	2.1	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =80A <sup>[5]</sup>	
On-Resistance		2.0	2.5	mΩ	V <sub>GS</sub> =4.5V, I <sub>D</sub> =80A <sup>[5]</sup>	
Gate Threshold Voltage	1.0		3.0	V	$V_{DS}=V_{GS}$ , $I_{D}=250$ uA	
ynamic Characteristics Essentially independent of operating tempe			ndent of operating temperature			
Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
Input Capacitance		5.4			V <sub>GS</sub> =0V,	
Reverse Transfer Capacitance		0.31		nF	V <sub>DS</sub> =25V,	
Output Capacitance		0.91			f=1.0MHz	
Gate Series Resistance		1.5		Ω	f=1.0MHz	
Total Gate Charge		63			V <sub>DD</sub> =20V, I <sub>D</sub> =192A, V <sub>GS</sub> =4.5V	
		115		nC	V/ -20V/	
Gate-to-Source Charge		15			V <sub>DD</sub> =20V, I <sub>D</sub> =192A, V <sub>GS</sub> =10V	
Gate-to-Drain (Miller) Charge		34				
e Switching Characteristics		1	Essential	y indepe	ndent of operating temperature	
Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
Turn-on Delay Time		10			V <sub>DD</sub> =20V	
Rise Time		24		no	$I_D = 182A$ $V_{GS} = 10V$ $R_G = 2.5\Omega$	
Turn-off Delay Time		77		115		
Fall Time		23				
Drain Body Diode Characteristic	CS		-	T_=	25 $^\circ\mathbb{C}$ unless otherwise specified	
Parameter	Min	Тур.	Max.	Unit	Test Conditions	
Continuous Source Current <sup>[2]</sup>			232	А	Maximum Ratings	
Diode Forward Voltage		0.9	1.2	V	I <sub>S</sub> =80A, V <sub>GS</sub> =0V	
Reverse Recovery Time		58		ns	V <sub>GS</sub> =0V	
Reverse Recovery Charge		47		nC	l <sub>F</sub> =20A,di/dt=100A/µs	
	Characteristics Parameter Input Capacitance Reverse Transfer Capacitance Output Capacitance Gate Series Resistance Total Gate Charge Gate-to-Source Charge Gate-to-Drain (Miller) Charge Switching Characteristics Parameter Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time Drain Body Diode Characteristic Parameter Continuous Source Current <sup>[2]</sup> Diode Forward Voltage Reverse Recovery Time	Characteristics         Parameter       Min.         Input Capacitance          Reverse Transfer Capacitance          Output Capacitance          Gate Series Resistance          Total Gate Charge          Gate-to-Source Charge          Gate-to-Drain (Miller) Charge          Switching Characteristics       Min.         Turn-on Delay Time          Rise Time          Turn-off Delay Time          Fall Time       Min         Orain Body Diode Characteristics       Min         Continuous Source Current <sup>[2]</sup> Diode Forward Voltage          Reverse Recovery Time	CharacteristicsParameterMin.Typ.Input Capacitance5.4Reverse Transfer Capacitance0.31Output Capacitance0.91Gate Series Resistance1.5Total Gate Charge63Total Gate Charge15Gate-to-Source Charge15Gate-to-Drain (Miller) Charge34Switching CharacteristicsMin.Typ.Turn-on Delay Time10Rise Time24Turn-off Delay Time77Fall Time23Drain Body Diode CharacteristicsMinTyp.Continuous Source Current <sup>[2]</sup> 0.9Reverse Recovery Time58	CharacteristicsEssentialParameterMin.Typ.Max.Input Capacitance5.4Reverse Transfer Capacitance0.31Output Capacitance0.91Gate Series Resistance1.5Total Gate Charge63Total Gate Charge115Gate-to-Source Charge15Gate-to-Drain (Miller) Charge34Switching CharacteristicsEssentialParameterMin.Typ.Max.Turn-on Delay Time10Rise Time24Turn-off Delay Time77Fall Time23Drain Body Diode CharacteristicsYanMax.Continuous Source Current <sup>[2]</sup> 232Diode Forward Voltage0.91.2Reverse Recovery Time58	CharacteristicsEssentially indeperParameterMin.Typ.Max.UnitInput Capacitance $5.4$ Input Capacitance $0.31$ InFOutput Capacitance $0.91$ InFInFInFOutput Capacitance $0.91$ InFInFOutput Capacitance $1.5$ $\Omega$ InFOutput Capacitance $1.5$ $\Omega$ InCGate Series Resistance $1.5$ $\Omega$ InCGate-to-Source Charge $15$ InFGate-to-Drain (Miller) Charge $34$ IntSwitching CharacteristicsEssentially indeperParameterMin.Typ.Max.Turn-on Delay Time $77$ InsFall Time $23$ InsOrain Body Diode Characteristics $T_J=7$ ParameterMinTyp.Max.ParameterMinTyp.Max.Inde Forward Voltage $0.9$ $1.2$ VReverse Recovery Time $58$ Ins	

Note:

[1] T<sub>J</sub>=25℃ to 175℃

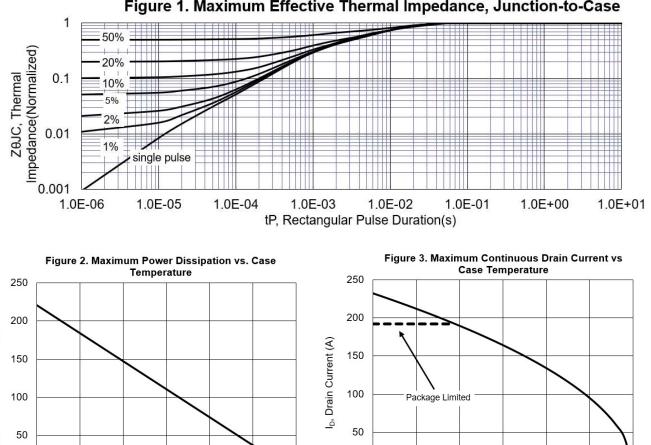
[2] Silicon limited current only

[3] Package limited current

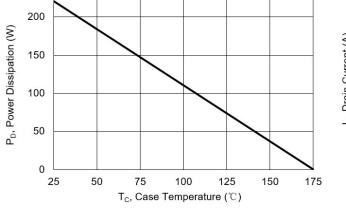
[4] Repetitive rating, pulse width limited by maximum junction temperature.

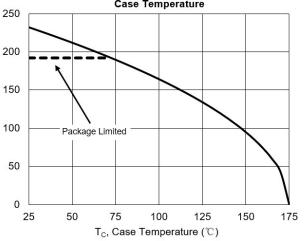
[5] Pulse width≤380µs; duty cycle≤2%.

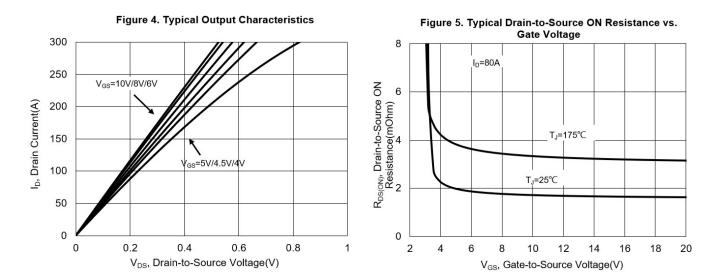




#### Figure 1. Maximum Effective Thermal Impedance, Junction-to-Case









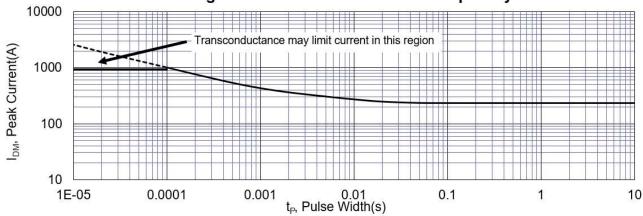


Figure 6. Maximum Peak Current Capability

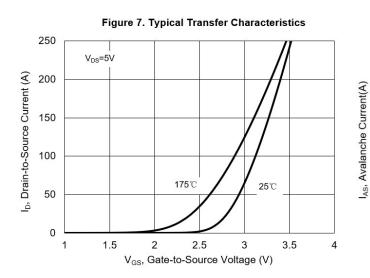
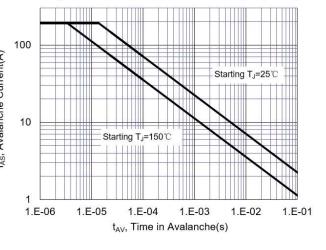
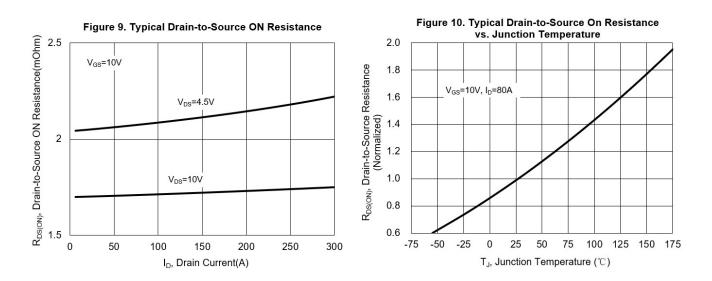


Figure 8. Unclamped Inductive Switching Capability

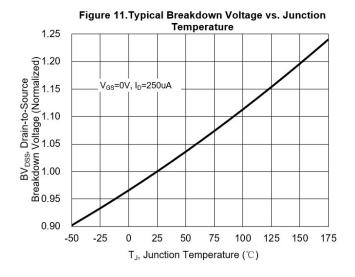




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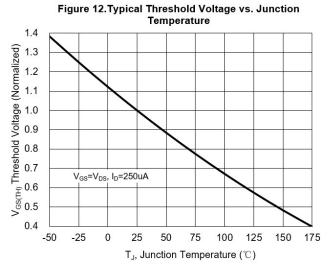


Figure 13. Maximum Forward Safe Operation Area

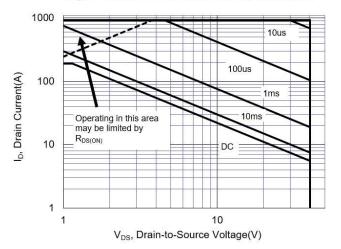
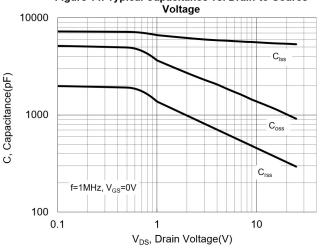
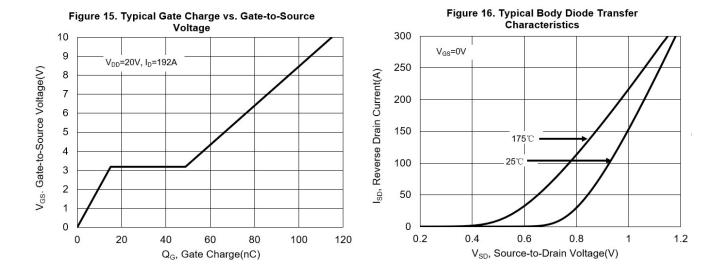


Figure 14. Typical Capacitance vs. Drain-to-Source



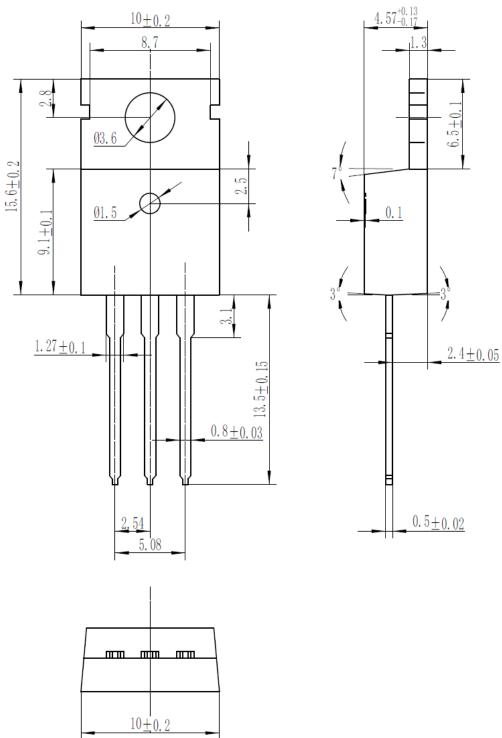


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# Package Dimensions

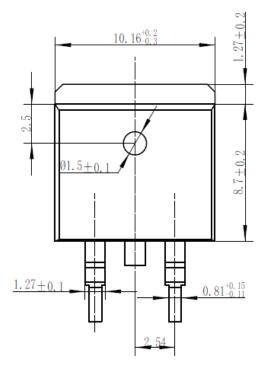
TO-220-3L

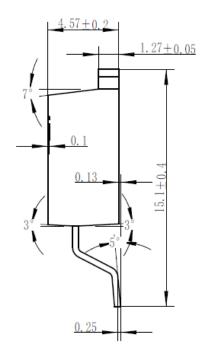


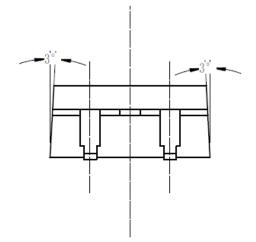




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